Bias, Variance, Model Complexity

· Quantitative

Loss function:
$$L(Y, \hat{f}(X)) = \begin{cases} (Y - \hat{f}(X))^2 \\ |Y - \hat{f}(X)| \end{cases}$$
 squared error absolute error

$$E_{rr_{T}} = E(L(Y, \hat{f}(X))|T)$$

$$E_{rr} = E[L(Y, \hat{f}(X))] = E[E_{rr}]$$

Training error:
$$\overline{err} = \overline{N} \stackrel{R}{\underset{i=1}{\sum}} L(y_i, \hat{f}(x_i))$$

· Qualitative

Loss function:
$$L(G, \hat{G}(X)) = \underline{I}(G \neq \hat{G}(X))$$
 (0-1 loss)

$$L(G, \hat{P}(X)) = -2 \underset{k=1}{\overset{K}{\succeq}} \underline{I}(G = k) \log \hat{P}_{k}(X)$$

$$= -2 (\alpha P_{G}(X)) (-2 \times \log - likelihood)$$

Training error:
$$\overline{err} = -\frac{2}{N} \sum_{i=1}^{N} \log \hat{p}_{gi}(x_i)$$

· Data-rich situation.

Train Validation	Test
------------------	------

· Insufficient data: AIC, BIC, MDL, SRM

Cross-validation and bootstrap

The Bias-Variance Decomposition

Assumption: $Y = f(X) + \varepsilon$, $E(\varepsilon) = 0$, $Var(\varepsilon) = \sigma_{\varepsilon}^{2}$

· Predicted error of a fit $\hat{f}(X)$ at $X=\infty$.

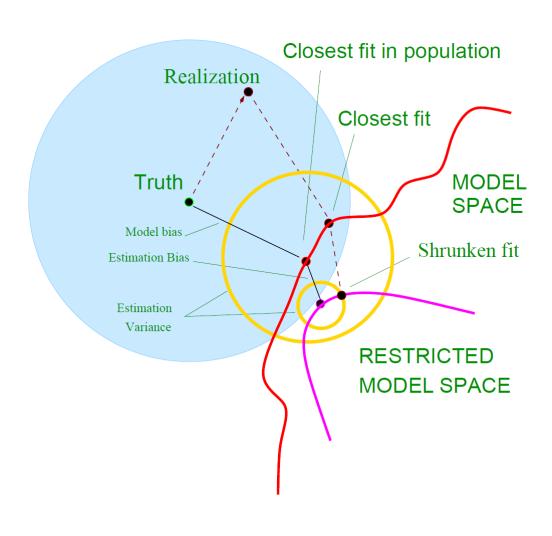
$$Err(x_0) = E[(Y - \hat{f}(x_0)^2 | X = x_0]$$

$$= E[(Y - \hat{f}(x_0) + \hat{f}(x_0) - \hat{f}(x_0)^2]$$

$$= \left[\left[\varepsilon^{2} \right] + \left[\left[\left(f(x_{0}) - \hat{f}(x_{0}) \right)^{2} \right] \right]$$

$$= \sigma_{\varepsilon}^{2} + E[f(x_{0}) - E(\hat{f}(x_{0})) + E(\hat{f}(x_{0})) - \hat{f}(x_{0})]^{2}$$

$$= \sigma_{\varepsilon}^{2} + \left[f(x_{0}) - E(\hat{f}(x_{0}))\right]^{2} + \left[E(\hat{f}(x_{0}) - E[\hat{f}(x_{0})])^{2}\right]^{2}$$



Optimism of the Training Error Rate

$$Err_{in} = \frac{1}{N} \sum_{i=1}^{N} E_{Y^{\circ}} (Y_{i}^{\circ} - \hat{f}(x_{i}))^{2}$$

$$\overline{err} = \frac{1}{N} \sum_{i=1}^{N} (y_{i} - \hat{f}(x_{i}))^{2}$$

$$W := \overline{F_y}(op) = \frac{2}{N} \sum_{i=1}^{N} Cov(\hat{y_i}, y_i)$$

proof:

yi is affected by yi
Yio is not affected by yi

$$W = E_{y} \left(\frac{1}{N} \sum_{i=1}^{N} E_{Y^{o}} \left[L(Y_{i}^{o}, \hat{f}(x_{i}) | T) \right] - \frac{1}{N} \sum_{i=1}^{N} L(y_{i}, \hat{f}(x_{i})) \right)$$

$$= \operatorname{Ey}\left(\frac{1}{N} \sum_{i=1}^{N} \operatorname{Eye}\left[\left(Y_{i}^{\circ} - \hat{y}_{i}\right)^{2}\right] - \sqrt{\sum_{i=1}^{N} \left(y_{i} - \hat{y}_{i}\right)^{2}}\right)$$

$$= \frac{1}{N} \sum_{i=1}^{N} (E_{y} E_{Y}[(Y_{i}^{\circ})^{2}] + E_{y} E_{Y}[\hat{y}_{i}^{2}] - 2E_{y} E_{Y}[Y_{i}^{\circ}\hat{y}_{i}]$$

-
$$E_{y}[y_{i}^{2}] - E_{y}[\hat{y}_{i}^{2}] + 2E_{y}[y_{i}\hat{y}_{i}]$$

$$\frac{E_{y}E_{y}[Y_{i}^{*}]^{2}=E_{y}[y_{i}^{*}]}{N} \sum_{i=1}^{N} \left(E(y_{i}\hat{y}_{i})-E(y_{i})E(\hat{y}_{i})\right)$$

$$=\sum_{i=1}^{N} \sum_{i=1}^{N} C_{ov}(y_{i},\hat{y}_{i})$$

$$\sum_{i=1}^{N} Cov(\hat{y}_i, y_i) = d \cdot \sigma_{\epsilon}^2 \quad (d \text{ inputs})$$

Estimates of In-sample Prediction Error

· AIC (Akaike information criterion)

$$-2 \cdot E(\log \Pr_{\theta}(Y)) \approx -\frac{2}{N} \cdot E(\log likelihood) + 2 \cdot \frac{d}{N}$$

$$\Rightarrow$$
 AIC= $-\frac{2}{N}\frac{N}{1}\log P_{\theta}(y_i) + 2\cdot\frac{d}{N}$

The Effective Number of Parameters

· Linear fitting method:
$$\hat{y} = Sy$$

$$\cdot \sum_{i=1}^{N} Cov(y_i, \hat{y_i}) = tr[Cov(y, \hat{y})] = tr[Cov(y, Sy)]$$

=
$$tr(\sigma_{\Sigma} \cdot S) = \sigma_{\Sigma} \cdot tr(S)$$

General definition:
$$df(\hat{y}) = \frac{\sum_{i=1}^{N} Cov(\hat{y}_i, y_i)}{\sigma_{\hat{z}_i}}$$

· With Penalty:
$$df(\alpha) = \sum_{m=1}^{M} \frac{\theta_m}{\theta_m + \alpha}$$
 θ_m is the m-th eigenvalue of Hessian Matrix

The Bayesian Approach and BIC

$$BIC = -2\log-likelihood + (\log N) \cdot d$$

$$= \frac{N}{\sigma_{\epsilon}^{2}} \left[\overline{err} + (\log N) \cdot \frac{d}{N} \cdot \sigma_{\epsilon}^{2} \right]$$
AIC has $k=2$
BIC has $k=\log N$

A set of candidate model $\{M_m\}_{m=1}^{3}$

Known distribution of parameter Om Pr(Om/Mm)

· P(Mm/Z) oc Pr(Mm)· Pr(Z/Mm)

oc Pr(Mm). SPr(Z10m.Mm). Pr(Om/Mm) dom

Bayes factor:
$$BF(z) = \frac{P_r(z|M_m)}{P_r(z|M_L)} = \frac{P_r(M_m)}{P_r(M_L)} \cdot \frac{P_r(z|M_m)}{P_r(z|M_L)}$$

· With Laplace approximation:

$$\log \Pr(Z|M_m) = \log \Pr(Z|\hat{\theta}_m, U_m) - \frac{d_m}{2} \cdot \log N + O(1)$$

· Posterior probability of model Mm:

$$P(M_m|Z) = \frac{e^{-\frac{1}{2}BIC_m}}{\sum_{l=1}^{M} e^{-\frac{1}{2}BIC_l}} = \frac{P(Z|M_m)P(M_m)}{\sum_{l=1}^{M} e^{-\frac{1}{2}BIC_l}}$$